

Q1 3-Phase TNPC Module NXH40T120L3Q1

The NXH40T120L2Q1 is a power module containing a three channel T-type neutral-point clamped (TNPC) circuit. Each channel has two 1200 V, 40 A IGBTs with inverse diodes and two 650 V, 25 A IGBTs with inverse diodes. The module contains an NTC thermistor.

Features

- Low Package Height
- Compact 82.5 mm x 37.4 mm x 12 mm Package
- Options with Press-fit Pins and Solder Pins
- Options with Pre-applied Thermal Interface Material (TIM) and without Pre-applied TIM
- Thermistor
- This Device is Pb-Free and is RoHS Compliant

Applications

- Solar Inverters
- UPS
- Energy Storage Systems

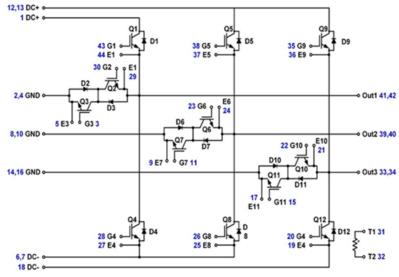
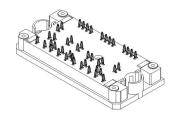


Figure 1. NXH40T120L3Q1 Schematic Diagram



Q1 3-TNPC CASE 180AS

Solder pins follow similar pattern

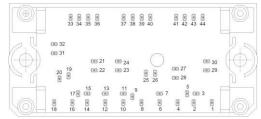
MARKING DIAGRAM



NXH40T120L3Q1x = Device Code A = Assembly Site Code T = Test Site Code

YYWW = Year and Work Week Code G = Pb-Free Package

PIN CONNECTIONS



ORDERING INFORMATION

See detailed ordering and shipping information on page 5 of this data sheet.

MAXIMUM RATINGS (Note 1)

Rating	Symbol	Value	Unit
IGBT (Q1, Q4, Q5, Q8, Q9, Q12)			
Collector – Emitter Voltage	VCES	1200	V
Gate – Emitter Voltage	VGE	±20	V
Continuous Collector Current @ T _C = 80°C (T _J = 175°C)	Ic	40	Α
Pulsed Collector Current (T _J = 175°C)	lCpulse	120	Α
Maximum Power Dissipation (T _J = 175°C)	Ptot	145	W
Minimum Operating Junction Temperature	Тумім	-40	°C
Maximum Operating Junction Temperature	ТЈМАХ	175	°C
DIODE (D1, D4, D5, D8, D9, D12)			
Peak Repetitive Reverse Voltage	VRRM	1200	V
Continuous Forward Current @ T _C = 80°C (T _J = 175°C)	I _F	25	Α
Repetitive Peak Forward Current (T _J = 175°C)	IFRM	75	Α
Maximum Power Dissipation (T _J = 175°C)	Ptot	55	W
Minimum Operating Junction Temperature	TJMIN	-40	°C
Maximum Operating Junction Temperature	TJMAX	175	°C
IGBT+DIODE (Q2+D2, Q3+D3, Q6+D6, Q7+D7, Q10+D10, Q11+D11)			
Collector – Emitter Voltage	VCES	650	V
Gate – Emitter Voltage	VGE	±20	V
Continuous Collector Current @ T _C = 80°C (T _J = 175°C)	I _C	42	Α
Pulsed Collector Current (T _J = 175°C)	lCpulse	126	Α
Maximum Power Dissipation (T _J = 175°C)	Ptot	146	W
Minimum Operating Junction Temperature	Тумім	-40	°C
Maximum Operating Junction Temperature	ТЈМАХ	175	°C
THERMAL PROPERTIES			
Storage Temperature range	Tstg	-40 to 150	°C
INSULATION PROPERTIES			
Isolation Test Voltage, t = 1 sec, 60 Hz	Vis	3000	VRMS
Creepage Distance		12.7	mm

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Refer to ELECTRICAL CHARACTERISTICS, RECOMMENDED OPERATING RANGES and/or APPLICATION INFORMATION for Safe

RECOMMENDED OPERATING CONDITIONS

Rating	Symbol	Min	Max	Unit
Module Operating Junction Temperature	T_J	-40	150	°C

Functional operation above the stresses listed in the Recommended Operating Ranges is not implied. Extended exposure to stresses beyond the Recommended Operating Ranges limits may affect device reliability.

Operating parameters.

ELECTRICAL CHARACTERISTICS (T_{.1} = 25°C Unless Otherwise Noted)

Parameter	Test Conditions	Symbol	Min.	Тур.	Max.	Unit
IGBT CHARACTERISTICS (Q1, Q4, Q5, C	Q8, Q9, Q12)					
Collector-Emitter Cutoff Current	V _{GE} = 0 V, V _{CE} = 1200 V	ICES	-	_	400	μΑ
Collector-Emitter Saturation Voltage	V _{GE} = 15 V, I _C = 40 A, T _J = 25°C	VCE(sat)	-	1.85	2.20	V
	V _{GE} = 15 V, I _C = 40 A , T _J = 150°C		_	2.25	-	
Gate-Emitter Threshold Voltage	$V_{GE} = V_{CE}, I_{C} = 1.5 \text{ mA}$	VGE(TH)	4.50	-	6.50	V
Gate Leakage Current	V _{GE} = 20 V, V _{CE} = 0 V	IGES	-	_	800	nA
Turn–on Delay Time		td(on)	-	63	_	ns
Rise Time	1	t _r	-	22	_	
Turn-off Delay Time	T _J = 25°C	td(off)	-	199	-	
Fall Time	V_{CE} = 350 V, I_{C} = 28 A, V_{GE} = ±15 V, R_{G} = 8 Ω	t _f	_	23	_	
Turn-on Switching Loss per Pulse	1	Eon	-	560	-	μJ
Turn off Switching Loss per Pulse	1	Eoff	-	338	-	
Turn–on Delay Time		td(on)	-	59	_	ns
Rise Time	1	t _r	_	24	_	
Turn-off Delay Time	T _J = 125°C	td(off)	-	225	-	
Fall Time	$V_{CE} = 350 \text{ V, } I_{C} = 28 \text{ A,}$ $V_{GE} = \pm 15 \text{ V, } R_{G} = 8 \Omega$	t _f	_	80	-	
Turn – on Switching Loss per Pulse		Eon	-	757	_	μJ
Turn off Switching Loss per Pulse	1	Eoff	-	910	-	
Input Capacitance		Cies	-	7753	-	pF
Output Capacitance	V _{CE} = 20 V V _{GE} = 0 V, f = 1 MHz	Coes	-	227	=	
Reverse Transfer Capacitance	1	Cres	-	127	_	
Total Gate Charge	$V_{CE} = 350 \text{ V}, I_{C} = 40 \text{ A}, V_{GE} = \pm 15 \text{ V}$	Q_g	_	536	_	nC
Thermal Resistance - chip-to-heatsink	Thermal grease, Thickness \leq 2.25 Mil, $\lambda = 2.9 \text{ W/mK}$	RthJH	-	1.01	-	°C/W
DIODE CHARACTERISTICS (D1, D4, D5,	D8, D9, D12)		•	•	•	
Diode Forward Voltage	I _F = 20 A, T _J = 25°C	V_{F}	_	2.4	2.7	V
	I _F = 20 A, T _J = 150°C		-	1.7	_	
Reverse Recovery Time		trr	-	43	_	ns
Reverse Recovery Charge	T 0500	Qrr	_	756	_	μC
Peak Reverse Recovery Current	$T_J = 25^{\circ}C$ $V_{CE} = 350 \text{ V, } I_C = 28 \text{ A,}$	IRRM	_	35	_	Α
Peak Rate of Fall of Recovery Current	$V_{GE} = \pm 15 \text{ V}, R_{G} = 16 \Omega$	di/dt	_	750	-	A/μs
Reverse Recovery Energy	1	Err	_	104	_	μJ
Reverse Recovery Time		trr	-	129	_	ns
Reverse Recovery Charge	<u> </u>	Qrr	-	2702	-	μC
Peak Reverse Recovery Current	$T_J = 125^{\circ}C$ $V_{CE} = 350 \text{ V, } I_C = 28 \text{ A,}$	IRRM	_	45	-	A
Peak Rate of Fall of Recovery Current	$V_{GE} = \pm 15 \text{ V}, R_G = 16 \Omega$	di/dt	_	407	_	A/μs
Reverse Recovery Energy	1	Err	_	428	-	μJ
Thermal Resistance - chip-to-heatsink	Thermal grease, Thickness \leq 2.25 Mil, λ = 2.9 W/mK	RthJH	-	1.63	-	°C/W

ELECTRICAL CHARACTERISTICS (T_{.I} = 25°C Unless Otherwise Noted) (continued)

Parameter	Test Conditions	Symbol	Min.	Тур.	Max.	Unit
IGBT CHARACTERISTICS (Q2, Q3, Q6, C	07, Q10, Q11)				•	
Collector-Emitter Cutoff Current	V _{GE} = 0 V, V _{CE} = 650 V	ICES	-	_	250	μА
Collector-Emitter Saturation Voltage	V _{GE} = 15 V, I _C = 50 A, T _J = 25°C	VCE(sat)	-	1.50	-	V
	V _{GE} = 15 V, I _C = 50 A , T _J = 150°C		-	1.53	_	
Gate-Emitter Threshold Voltage	$V_{GE} = V_{CE}, I_{C} = 1.65 \text{ mA}$	VGE(TH)	2.60	4.40	6.40	V
Gate Leakage Current	V _{GE} = 20 V, V _{CE} = 0 V	IGES	-	_	400	nA
Turn-on Delay Time		td(on)	-	54	_	ns
Rise Time	1	t _r	-	15	_	
Turn-off Delay Time	T _J = 25°C	td(off)	-	157	-	
Fall Time	V_{CE} = 350 V, I_C = 28 A, V_{GE} = ±15 V, R_G = 16 Ω	t _f	_	12	_]
Turn-on Switching Loss per Pulse		Eon	=	416	=	μJ
Turn off Switching Loss per Pulse		Eoff	-	321	_	
Turn-on Delay Time		td(on)	_	52	-	ns
Rise Time	1	t _r	_	16	_	
Turn-off Delay Time	T _J = 125°C	td(off)	-	178	-	
Fall Time	V_{CE} = 350 V, I_{C} = 28 A, V_{GE} = ±15 V, R_{G} = 16 Ω	t _f	-	18	=]
Turn – on Switching Loss per Pulse		Eon	_	671	-	μJ
Turn off Switching Loss per Pulse		Eoff	-	444	_	
Input Capacitance		Cies	-	3137	-	pF
Output Capacitance	$V_{CE} = 20 \text{ V } V_{GE} = 0 \text{ V, f} = 1 \text{ MHz}$	Coes	-	146	_	
Reverse Transfer Capacitance		Cres	=	17	=	
Total Gate Charge	$V_{CE} = 350 \text{ V}, I_{C} = 40 \text{ A}, V_{GE} = \pm 15 \text{ V}$	Q_g	-	180	_	nC
Thermal Resistance - chip-to-heatsink	Thermal grease, Thickness \leq 2.25 Mil, $\lambda = 2.9 \text{ W/mK}$	RthJH	=	0.995	=	°C/W
DIODE CHARACTERISTICS (D2, D3, D6,	D7, D10, D11)	Į.		.1	I	
Diode Forward Voltage	I _F = 20 A, T _J = 25°C	V _F	-	1.28	_	V
	I _F = 20 A, T _J = 150°C		-	1.18	_	
Combined IGBT + Diode Voltage Drop	I _F = 20 A, T _J = 25°C	V _F	=	3.05	3.4	V
Reverse Recovery Time		trr	=	69	=	ns
Reverse Recovery Charge	T	Qrr	_	1267	-	μС
Peak Reverse Recovery Current	$T_J = 25^{\circ}C$ $V_{CE} = 350 \text{ V, } I_C = 28 \text{ A,}$	IRRM	-	41	_	Α
Peak Rate of Fall of Recovery Current	$V_{GE} = \pm 15 \text{ V}, R_G = 8 \Omega$	di/dt	-	1599	_	A/μs
Reverse Recovery Energy		Err	-	244	_	μJ
Reverse Recovery Time		trr	-	111	_	ns
Reverse Recovery Charge	_	Qrr	=	2323	=	μC
Peak Reverse Recovery Current	$T_J = 125^{\circ}C$ $V_{CE} = 350 \text{ V, } I_C = 28 \text{ A,}$	IRRM	-	40	_	Α
Peak Rate of Fall of Recovery Current	$V_{GE} = \pm 15 \text{ V}, \ R_G = 8 \ \Omega$	di/dt	-	470	_	A/μs
Reverse Recovery Energy	1	Err	_	510	_	μJ

$\textbf{ELECTRICAL CHARACTERISTICS} \ (T_J = 25^{\circ}\text{C Unless Otherwise Noted}) \ (continued)$

Parameter	Test Conditions	Symbol	Min.	Тур.	Max.	Unit
THERMISTOR CHARACTERISTICS	•	•			•	
Nominal resistance	T = 25°C	R25		22		kΩ
Nominal resistance	T = 100°C	R100		1468		Ω
Deviation of R25		R/R	-5		5	%
Power dissipation		P_{D}		200		mW
Power dissipation constant				2		mW/K
B-value	B(25/50), tolerance ±3%			3950		K
B-value	B(25/100), tolerance ±3%			3998		K

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

ORDERING INFORMATION

Orderable Part Number	Marking	Package	Shipping
NXH40T120L3Q1PG	NXH40T120L3Q1PG	Q1 3-Phase TNPC - Case 180AS Press-fit Pins (Pb-Free)	21 Units / Blister Tray
NXH40T120L3Q1SG	NXH40T120L3Q1SG	Q1 3-Phase TNPC - Case 180BN Solder Pins (Pb-Free)	21 Units / Blister Tray
NXH40T120L3Q1PTG	NXH40T120L3Q1PTG	Q1 3-Phase TNPC - Case 180AS Press-fit Pins (Pb-Free)	21 Units / Blister Tray

TYPICAL CHARACTERISTICS - HALF BRIDGE IGBT (Q1, Q4, Q5, Q8, Q9, Q12) AND DIODE (D1, D4, D5, D8, D9, D12)

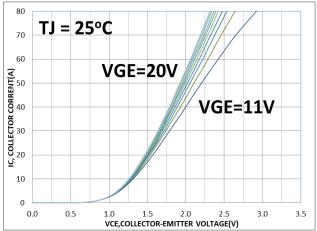


Figure 2. Typical Output Characteristics

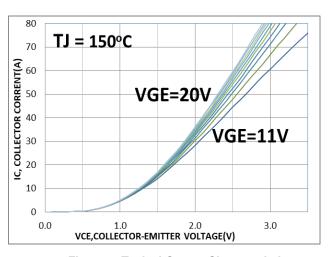


Figure 3. Typical Output Characteristics

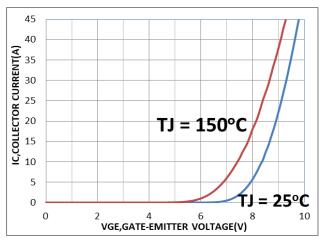


Figure 4. Typical Transfer Characteristics

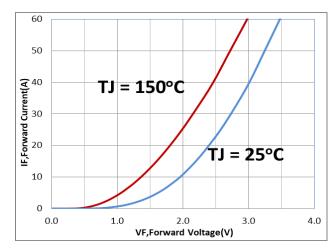


Figure 5. Diode Forward Characteristics

TYPICAL CHARACTERISTICS - HALF BRIDGE IGBT (Q1, Q4, Q5, Q8, Q9, Q12) AND DIODE (D1, D4, D5, D8, D9, D12)

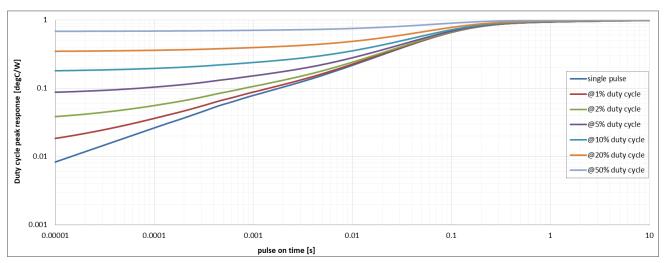


Figure 6. Transient Thermal Impedance (Half Bridge IGBT)

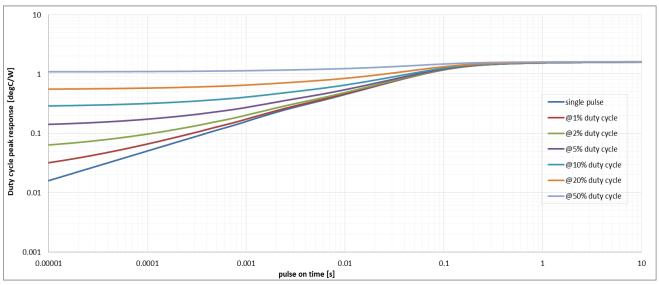
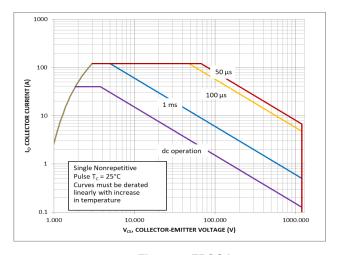


Figure 7. Transient Thermal Impedance (Half Bridge Diode)

TYPICAL CHARACTERISTICS – HALF BRIDGE IGBT (Q1, Q4, Q5, Q8, Q9, Q12) AND DIODE (D1, D4, D5, D8, D9, D12)



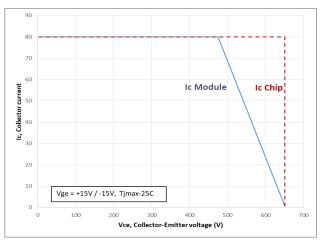


Figure 8. FBSOA

Figure 9. RBSOA

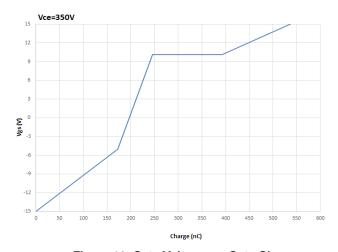


Figure 10. Gate Voltage vs. Gate Charge

TYPICAL CHARACTERISTICS - NP IGBT + DIODE (Q2+D2, Q3+D3, Q6+D6, Q7+D7, Q10+D10, Q11+D11)

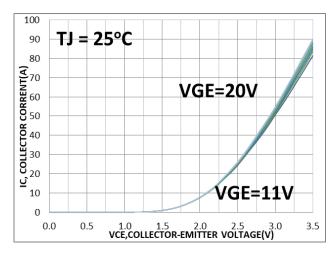


Figure 11. Typical Output Characteristics $(I_C \text{ versus } V_{DT})$

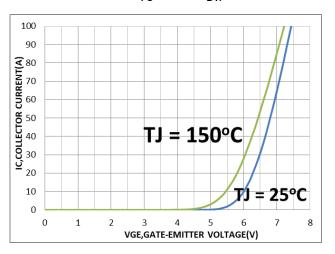


Figure 13. Typical Transfer Characteristics

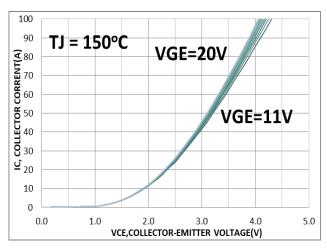


Figure 12. Typical Output Characteristics (I_C versus V_{DT})

TYPICAL CHARACTERISTICS - NP IGBT + DIODE (Q2+D2, Q3+D3, Q6+D6, Q7+D7, Q10+D10, Q11+D11)

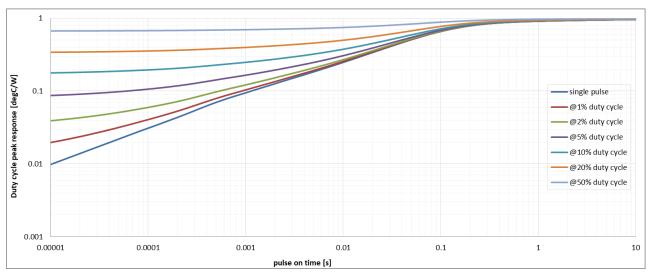


Figure 14. Transient Thermal Impedance (Neutral Point IGBT + Diode)

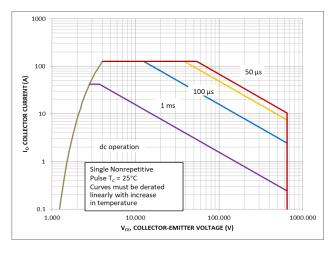


Figure 15. FBSOA (NP IGBT + Diode)

Figure 16. RBSOA (NP IGBT + Diode)

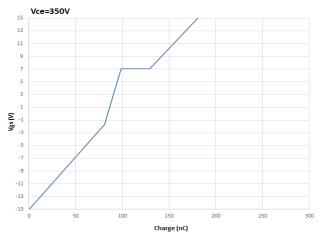


Figure 17. Gate Voltage vs. Gate Charge

TYPICAL CHARACTERISTICS - HALF BRIDGE IGBT COMMUTATES NEUTRAL POINT DIODE

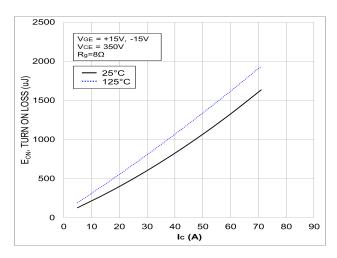


Figure 18. Typical Switching Loss E_{ON} vs. I_{C}

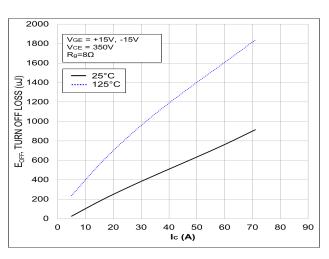


Figure 19. Typical Switching Loss E_{OFF} vs. I_C

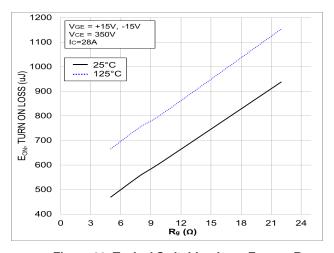


Figure 20. Typical Switching Loss E_{ON} vs. R_G

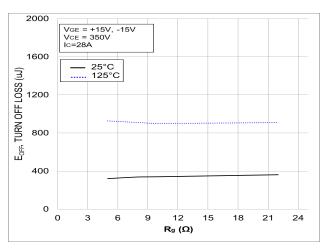


Figure 21. Typical Switching Loss E_{OFF} vs. R_G

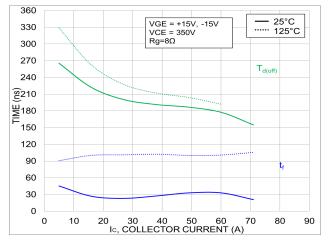


Figure 22. Typical Switching Time T_{DOFF} vs. I_C

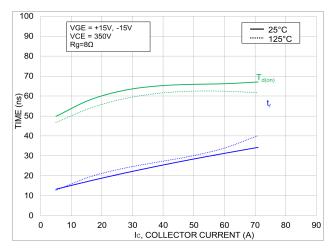
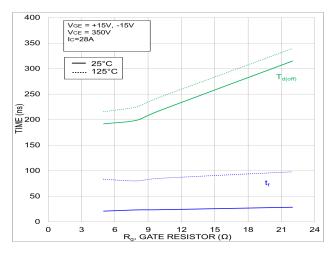


Figure 23. Typical Switching Time T_{DON} vs. I_{C}

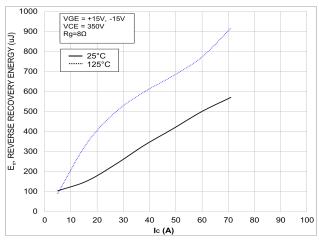
TYPICAL CHARACTERISTICS - HALF BRIDGE IGBT COMMUTATES NEUTRAL POINT DIODE



140 120 — 25°C ---- 125°C 100 (E)80 TIME t, 60 40 20 0 0 3 21 24 9 12 15 18 R_g, GATE RESISTOR (Ω)

Figure 24. Typical Switching Time T_{DOFF} vs. R_G

Figure 25. Typical Switching Time T_{DON} vs. R_{G}



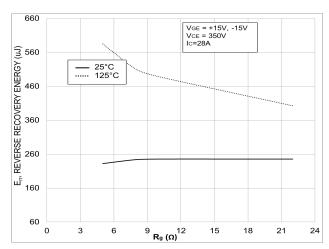
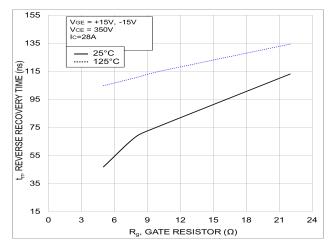


Figure 26. Typical Reverse Recovery Energy Loss vs. I_C

Figure 27. Typical Reverse Recovery Energy Loss vs. R_G



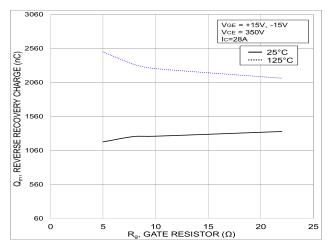
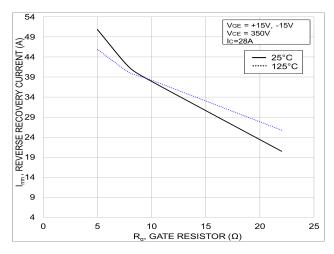


Figure 28. Typical Reverse Recovery Time vs. $$\rm R_{\rm G}$$

Figure 29. Typical Reverse Recovery Charge vs. R_G

TYPICAL CHARACTERISTICS - HALF BRIDGE IGBT COMMUTATES NEUTRAL POINT DIODE

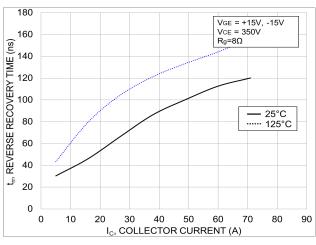


3000

| Voe = +15V, -15V | Voe = 350V | Ic=28A |
| 2500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500 | | 1500

Figure 30. Typical Reverse Recovery Peak Current vs. R_G

Figure 31. Typical di/dt vs. $R_{\mbox{\scriptsize G}}$



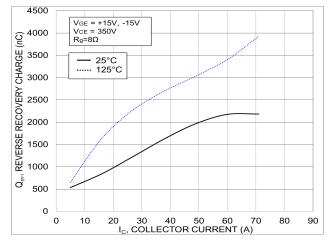
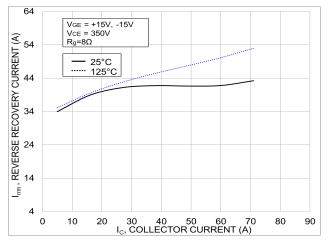


Figure 32. Typical Reverse Recovery Time vs.

Figure 33. Typical Reverse Recovery Charge vs. I_C



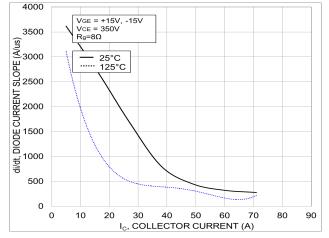


Figure 34. Typical Reverse Recovery Current vs. I_C

Figure 35. Typical di/dt Current Slope vs. I_C

TYPICAL CHARACTERISTICS - NEUTRAL POINT IGBT COMMUTATES HALF BRIDGE DIODE

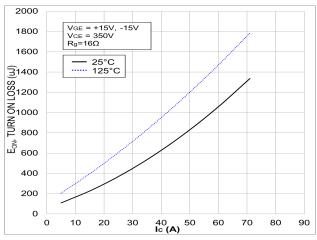


Figure 36. Typical Turn ON Loss vs. I_C

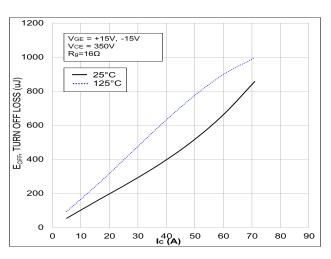


Figure 37. Typical Turn OFF Loss vs. I_C

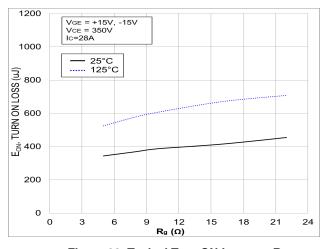


Figure 38. Typical Turn ON Loss vs. R_G

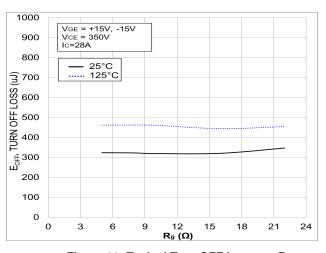


Figure 39. Typical Turn OFF Loss vs. $R_{\mbox{\scriptsize G}}$

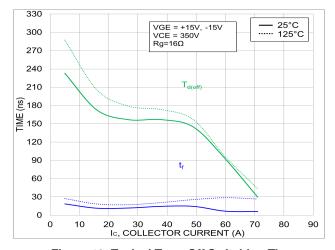


Figure 40. Typical Turn–Off Switching Time vs. $\rm I_{\rm C}$

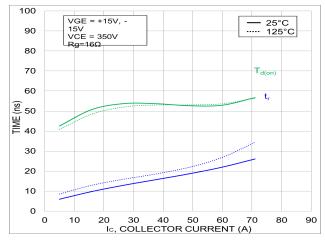


Figure 41. Typical Turn–On Switching Time vs. I_{C}

TYPICAL CHARACTERISTICS - NEUTRAL POINT IGBT COMMUTATES HALF BRIDGE DIODE

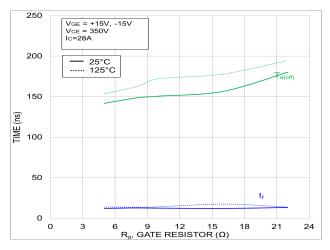


Figure 42. Typical Turn–Off Switching Time vs. $$\rm R_{\rm G}$$

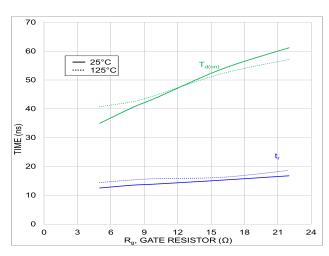


Figure 43. Typical Turn-On Switching Time vs. R_G

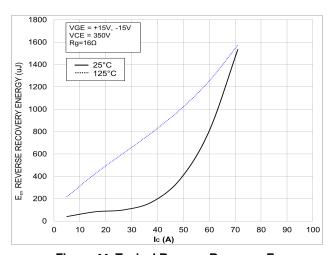


Figure 44. Typical Reverse Recovery Energy Loss vs. I_C

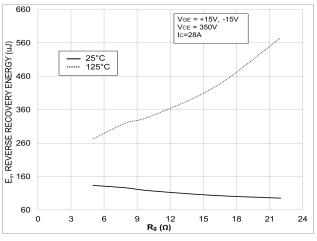


Figure 45. Typical Reverse Recovery Energy Loss vs. R_G

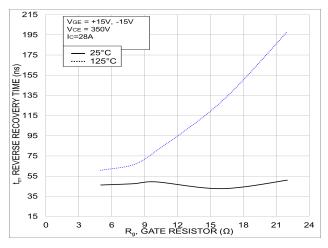


Figure 46. Typical Reverse Recovery Time vs. $$\rm R_{\rm G}$$

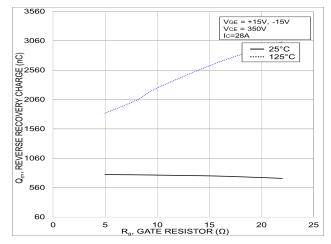
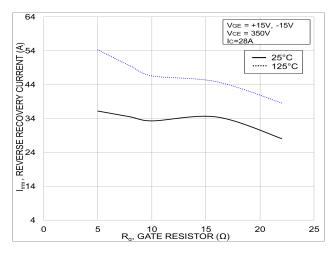


Figure 47. Typical Reverse Recovery Charge vs. R_G

TYPICAL CHARACTERISTICS - NEUTRAL POINT IGBT COMMUTATES HALF BRIDGE DIODE



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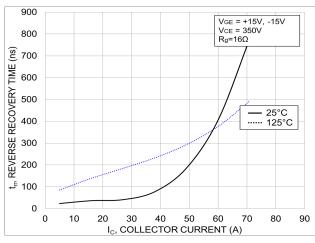
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Figure 48. Typical Reverse Recovery Peak Current vs. R_G

Figure 49. Typical di/dt vs. R_G



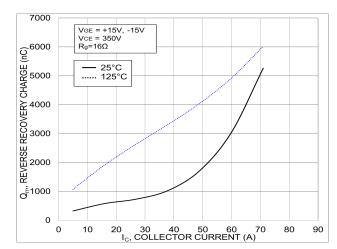
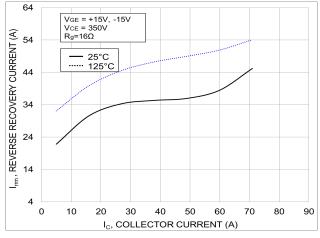


Figure 50. Typical Reverse Recovery Time vs.

Figure 51. Typical Reverse Recovery Charge vs. I_C



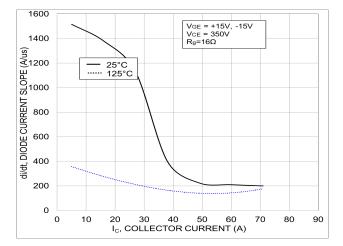
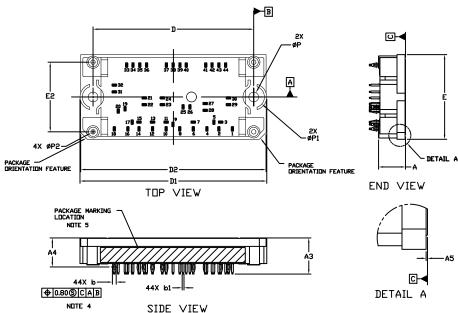


Figure 52. Typical Reverse Recovery Current vs. I_C

Figure 53. Typical di/dt Current Slope vs. I_{C}

PIM44, 71x37.4 CASE 180AS ISSUE O

DATE 25 JUN 2018



	PIN POSITION		Τ		PIN PE	ISITION
PIN	х	Υ		PIN	×	Υ
1	26.10	14.10		23	-4.85	3.40
a	20.10	14.10		24	-4.85	0.40
з	20.90	11.10		25	4.30	4.40
4	14.80	14.10		26	7.30	4.40
5	17.90	11.10		27	14.05	2.90
6	8.80	14.10		28	14.05	5.90
7	8.80	11.10		29	24.35	3.40
æ	2.80	14.10		30	24.35	0.40
9	-0.20	12.10		31	-26.10	-2.25
10	-3.20	14.10		32	-26.10	-5.25
11	-3.20	11.10		33	-20.65	-14.10
12	-9.20	14.10		34	-17.85	-14.10
13	-9.20	11.10		35	-14.85	-14.10
14	-15.20	14.10		36	-11.85	-14.10
15	-15.20	11.10		37	-3.10	-14.10
16	-20.10	14.10		38	-0.10	-14.10
17	-18.20	11.10		39	2.90	-14.10
18	-26.10	14.10		40	5.70	-14.10
19	-21.35	5.20		41	14.30	-14.10
20	-24.35	6.20		42	17.10	-14.10
21	-12.85	0.40		43	20.10	-14.10
55	-12.85	3.40		44	23.10	-14.10

NOTE 4

12.50

16.50

0.30

1.71

0.85 71.50

83.00

82.50

37.90

31.30

4.50

9.70

2.20

MILLIMETERS MIN.

11.50

15.50

0.10

1.61

0.75

70.50

82.00

81.50

36.90

30.30

4.10

9.30

1.80

АЗ

Α4

A5

b

b1

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D1

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Ε

E2

Р

P1

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N□M.

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12.83 BSC

0.20

1.66

0.80

71.00

82.50

82.00

37.40

30.80

4.30

9.50

2.00

	PIN P	NDITIZE		PIN P	ISITION
PIN	Х	Y	PIN	X	Y
1	26.10	-14.10	23	-4.85	-3.40
2	20.10	-14.10	24	-4.85	-0.40
3	20.90	-11.10	25	4.30	-4.40
4	14.80	-14.10	26	7.30	-4.40
5	17.90	-11.10	27	14.05	-2.90
6	8.80	-14.10	28	14.05	-5.90
7	8.80	-11.10	29	24.35	-3.40
8	2.80	-14.10	30	24.35	-0.40
9	-0.20	-12.10	31	-26.10	2.25
10	-3.20	-14.10	32	-26.10	5.25
11	-3.20	-11.10	33	-20.65	14.10
12	-9.20	-14.10	34	-17.85	14.10
13	-9.20	-11.10	35	-14.85	14.10
14	-15.20	-14.10	36	-11.85	14.10
15	-15.20	-11.10	37	-3.10	14.10
16	-20.10	-14.10	38	-0.10	14.10
17	-18.20	-11.10	39	2.90	14.10
18	-26.10	-14.10	40	5.70	14.10
19	-21.35	-5.20	41	14.30	14.10
20	-24.35	-6.20	42	17.10	14.10
21	-12.85	-0.40	43	20.10	14.10
22	-12.85	-3.40	44	23.10	14.10

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0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0	2X #99.20 THRU HOLE
Ø1.45-/ PLATED THRU HOLE	HOLE LOCATIONS
DECUMPENDED	

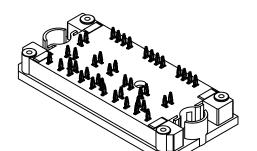
RECOMMENDED MOUNTING PATTERN

NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
- CONTROLLING DIMENSION: MILLIMETERS
- DIMENSIONS 6 AND 61 APPLY TO THE PLATED TERMINALS AND ARE MEASURED AT DIMENSION A4.
- POSITION OF THE CENTER OF THE TERMINALS IS DETERMINED FROM DATUM B THE CENTER OF DIMENSION D, X DIRECTION, AND FROM DATUM A, Y DIRECTION. POSITIONAL TOLERANCE, AS NOTED IN DRAWING, APPLIES TO EACH TERMINAL IN BOTH DIRECTIONS.
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PIM44, 71x37.4 CASE 180AS ISSUE O

DATE 15 JUN 2018

GENERIC MARKING DIAGRAM*

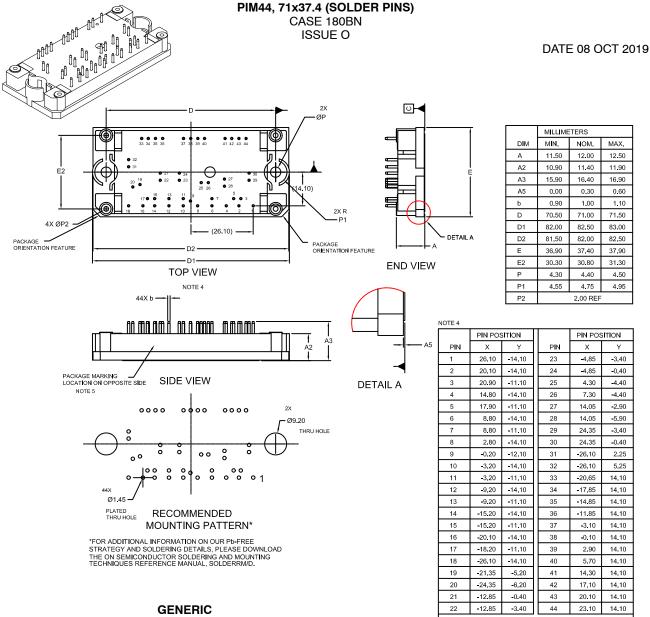
ATYYWW

> XXXXX = Specific Device Code = Pb-Free Package = Assembly & Test Site Code ΑT YYWW = Year and Work Week Code

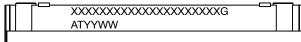
*This information is generic. Please refer to device data sheet for actual part marking. Pb–Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

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MARKING DIAGRAM*



XXXXX = Specific Device Code G = Pb-Free Package

AT = Assembly & Test Site Code YYWW = Year and Work Week Code

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

NOTES

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- 2. CONTROLLING DIMENSION: MILLIMETERS
- 3. DIMENSIONS 6 APPLIES TO THE PLATED TERMINALS AND IS MEASURED BETWEEN 1.00 AND 3.00 FROM THE TERMINAL TIP.
- 4. POSITION OF THE CENTER OF THE TERMINALS AND MOUNTING
 HOLES IS DETERMINED FROM DATUM B THE CENTER OF DIMENSION D,
 X DIRECTION, AND FROM DATUM A, Y DIRECTION. POSITIONAL
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